Substrate-induced magnetic ordering of rare-earth overlayers

P. A. Dowben,* D. LaGraffe, Dongqi Li, A. Miller, and Ling Zhang Department of Physics, Syracuse University, Syracuse, New York 13244-1130

> L. Dottl and M. Onellion University of Wisconsin, Madison, Wisconsin 53706 (Received 1 August 1990)

We have studied the magnetic ordering of terbium overlayers on Cu(100) and Ni(111), using angle-resolved photoemission. The $5p_{3/2}$ to $5p_{1/2}$ shallow-core-level branching ratios in different photoemission geometries provide a measure of the magnetic ordering in rare-earth-metal overlayers as a result of final-state effects in photoemission. We find that ferromagnetic substrates order paramagnetic terbium overlayers. This induced magnetic ordering is not a crystal-field effect and can be modeled by Ginzburg-Landau theory. Application of Ginzburg-Landau theory to our results suggests that the correlation length of paramagnetic terbium κ^{-1} is between 2.5 and 3.5 Å. Reversible increases in the extent of magnetic ordering at temperatures below the Tb Curie temperature are observed for terbium overlayers on both Cu(100) and Ni(111).

INTRODUCTION

We have recently introduced a technique for probing local magnetic ordering using conventional angleresolved photoemission¹⁻⁵ without spin detection of the photoelectrons. By measuring the 5p core levels in different photoemission geometries, the magnetic ordering of Gd overlayers¹⁻³ and Tb overlayers^{4,5} has been characterized. This technique is sensitive to the presence of conduction-band ferrimagnetic ordering, but does not distinguish the type of ferrimagnetic interactions between transition metals and rare earths by this technique, as has been described in preliminary communications.^{4,5}

There has been considerable interest in the magnetic interactions between transition metals and rare earths of both an experimental⁴⁻²¹ and theoretical²²⁻²⁵ nature. While the majority of this work has been directed toward Gd overlayers^{6-11,14,15,17-20,22-25} there is increasing interest in other rare-earth overlayers such as terbium.^{4,5,12,15-17} In general, it has been observed that the rare-earth overlayers couple antiferromagnetically with ferromagnetic substrates^{8-11,14,17} and exhibit properties (such as dichroism¹² or Auger electron polarization¹⁵) attributable to magnetic ordering that are strongly dependent upon substrate temperature and overlayer thickness.

There has been an increasing effort to develop the Ginzburg-Landau equation to model the magnetization in overlayers deposited on ferromagnetic substrates.²⁶⁻³⁷ In this paper we demonstrate that for paramagnetic rare-earth overlayers, the changes in magnetization with changes in thickness are accurately described by a Ginzburg-Landau model. Terbium was chosen for these studies because of the low terbium Curie temperature (215 K) which permits investigation of the ferromagnetic and paramagnetic phases without complications associated with interdiffusion and alloy formation.

EXPERIMENT

The experiments were performed in an ultrahighvacuum (UHV) system equipped with a hemispherical analyzer for angle-resolved photoemission and a retarding-field analyzer for low-energy electron diffraction (LEED) described previously.³ The light source for the photoemission studies was the 1-GeV ring at the Synchrotron Radiation Center, dispersed by 3-m and 6-m toroidal grating monochromators. The energy resolution (analyzer and monochromator) of the photoemission spectra collected by the hemispherical analyzer varied from 0.15 to 0.3 eV full width at half maximum.

The incidence angle of the light is defined with respect to the surface normal so that normal incidence (zero degrees) has vector potential completely parallel to the surface (s-polarized) while glancing incidence light has a large component of the vector potential normal to the surface (p polarized) throughout this work to preserve symmetry selection rules.

Both the Cu(100) and Ni(111) surfaces were cleaned by 2-keV Ar^+ -ion bombardment and carefully annealed. Temperatures were determined by nickel-alumel thermocouples and the crystals could be cooled to 140–170 K. Deposition of terbium followed procedures successfully developed for gadolinium as described elsewhere.³

The deposited thickness of our films was determined using an oscillating-crystal thin-film-thickness monitor, but the absolute thickness of our films was calibrated based upon changes in the core-level binding-energy shift and the relative terbium substrate photoemission signals. We have used substrate copper and terbium 4f bindingenergy shifts to establish and confirm terbium coverages for coverages up to a monolayer. This procedure is based upon surface to bulk core-level shift arguments^{38,39} and has been successfully used with gadolinium overlayers.^{3,40}

There is some evidence for copper interdiffusion with

terbium overlayers even at room temperature. For this reason, results obtained in this work were repeated at substrate temperatures in the region of 200 K. While interdiffusion of terbium with the nickel substrate cannot be completely ruled out, emission-angle-dependent studies suggest an abrupt interface and no evidence for interdiffusion was observed for substrate temperatures less than 300 K.

As with gadolinium on Cu(100) (Ref. 3) and terbium on Fe(100),¹⁵ the growth mode of terbium on both Cu(100) and Ni(111) is not epitaxial. We suggest that the growth mode is a simultaneous multilayer growth. For this reason, the thicknesses denote monolayer (ML) or angstrom equivalents and do not represent a uniform thickness, throughout this work.

RESULTS

There is a wealth of terbium valence features as seen in Figs. 1 and 2. This is, in part, a result of the 4*f* multiplets.⁴¹⁻⁴⁴ The 4*f* final states can be identified by comparison with x-ray photoemission spectra.⁴¹⁻⁴³ The various multiplets have binding energies at 2.2±0.1 eV and 2.8±0.1 eV (${}^{8}S_{7/2}$), 7.6±0.1 eV and 8.0±0.1 eV (${}^{6}D, {}^{6}P, {}^{6}I$), and 9.5±0.1 eV and 10.4±0.1 eV (${}^{6}F, {}^{6}H, {}^{6}G$) for thick films.

These terbium 4f level binding energies are observed to change with overlayer thickness, particularly the ${}^{8}S_{7/2}$ multiplet which overlaps the substrate Cu 3d or Ni 3d bands. The binding energies will also change with photon energy⁴⁵ as a result of the changing oscillator strengths of the different 4f levels. The feature at between 5.3 ± 0.1 eV to 5.9 ± 0.1 eV is an intrinsic feature that has been attributed to a many-electron correlation satellite described previously⁴⁶ and is consistent with a re-



FIG. 1. Photoemission spectra of terbium overlayers on Cu(100), for light incidence angles of 34° (s polarized) and 70° (p polarized). All photoelectrons were collected normal to the surface.



FIG. 2. Photoemission spectra of terbium overlayers on Ni(111), for light incidence angles of 40° (s polarized) and 70° (p polarized). All photoelectrons were collected normal to the surface. The terbium 4f multiplets are indicated at bottom.

cent experimental band structure of bulk terbium.⁴⁷

For terbium on Cu(100), the terbium 5d states have greater intensity with increasing p polarization of the incident light, as seen in Fig. 1. This is readily apparent when comparing the 5d intensity relative to the Cu 3d states (3 to 3.8 eV binding energy) and Tb 4f multiplets. This is true, independent of coverage, except for terbium films of submonolayer coverage. Since the 4f levels are less likely to have a well-defined spatial symmetry axis in one direction,^{3,43} from Fermi's golden rule we can infer that the terbium 5d states are largely of $d_{3z^2-r^2}$ character. Similar results have been obtained for gadolinium overlayers on Cu(100).³

Terbium overlayers on Ni(111) exhibit different 5dsymmetries for the states near the Fermi energy. There is a decreasing photoemission intensity of the combined Ni 3d and Tb 5d states at the Fermi energy (Fig. 2) with increasing p polarization of the incident light for 1–2-ML Tb films. This is most easily observed by comparing the Tb 5d and Ni 3d intensities with the Tb 4f intensities. We can infer that the symmetry of these states is of largely $d_{xz,yz}$ character, since s-polarized light selectively excites these states.^{48,49} The d-band density of states away from the Fermi energy behaves in a reverse manner for thin [1–2 ML of terbium on Ni(111)]. Increasing p polarization of the incident light results in increased emission and these d-band states away from (not at E_F) the Fermi energy are therefore of $d_{3r^2-r^2}$ character. As the thickness of the film increases, this behavior changes. For thick Tb films it is clear that the states at the Fermi energy are of $d_{3z^2-r^2}$ character. A similar change in level ordering of the different symmetry bands with crystal substrate (as observed with terbium on copper as opposed to nickel) has been previously observed in halogen and chalcogen overlayers.^{50–52}

The Tb $5p_{1/2}$ and $5p_{3/2}$ levels, at binding energies of 28.4±0.2 eV and 22.±0.2 eV, respectively, also exhibit changing intensities with changing light polarization. Figure 3 shows these changes for terbium overlayers on Ni(111) and Fig. 4 terbium overlayers on Cu(100), and temperatures of about 170 K.

The manner in which the terbium 5p core levels depend on light polarization can be measured qualitatively on a relative scale from the ratio of $5p_{3/2}$ to $5p_{1/2}$ level intensities in different light polarization and normal emission. This ratio, the ratio of the 5p branching ratios (the $5p_{1/2}$ intensity divided by the $5p_{3/2}$ intensity) for p- and s-polarized light is denoted as the *p*-level anisotropy β_p / β_s .⁴ The *p*-level anisotropy has been measured and plotted for a variety of terbium film thickness on Cu(100) (Fig. 5) and Ni(111) (Fig. 6) well above (300 K) and well below (170 K) the Curie temperature of terbium [215 K (Ref. 53)]. Note that for terbium on Cu(100), the *p*-level anisotropy measurements taken at room temperature are independent of coverage. These results shown in Fig. 5 demonstrate that the room-temperature p-level anisotropy of 0.82 is not the statistical value of 1.0. Above T_c , the *p*-level anisotropy depends on the overlayer coverage for terbium on Ni(111) (Fig. 6).

By changing the terbium overlayer temperature, there



FIG. 3. The changing terbium 5p intensities across the Tb Curie temperature for a one-monolayer (nominal film thickness) thick film of terbium on Ni(111). The changes are reversible. The photon energy is 60 eV, and all photoelectrons are collected normal to the surface..



FIG. 4. The changing terbium 5p intensities across the Tb Curie temperature for a monolayer (nominal film thickness) thick film of terbium on Cu(100). The photon energy is 60 eV, and all photoelectrons are collected normal to the surface.

are clearly significant changes in the *p*-level anisotropy as seen in Figs. 3 and 4. These changes are reversible for several cycles of temperature change above and below T_c . For thin terbium overlayers on Ni(111), the *p*-level anisotropy is observed to increase with a decrease in temperature from above T_c to below T_c . For the thick terbium films on Ni(111), the *p*-level anisotropy is observed to decrease from 1.6 ± 0.2 (300 K) to 0.5 ± 0.1 (170 K).

DISCUSSION

The *p*-level anisotropy is normally not expected to deviate from unity³ but as has been discussed in detail elsewhere 1^{-4} some enhancement of the $5p_{3/2}$ intensity is expected in some photoemission geometries as a result of long-range magnetic ordering. While core *p* levels should



FIG. 5. The *p*-level anisotropy for terbium on Cu(100) at temperatures well above the terbium Curie temperature. Note that there is no variation with film thickness. Data are reduced from spectra as shown in Fig. 3. The line at 0.82 indicates the average value.



FIG. 6. The *p*-level anisotropy for terbium on Ni(111) at room temperature (+) and at 170 K (0) as a function of film thickness. The expected *p*-level anisotropy of unity (---) in the absence of ferromagnetic ordering is indicated. Crystal-field effect variations should fall *between* the two solid lines. The arrows indicate the reversible increase in the *p*-level anisotropy upon long-range ferromagnetic ordering. The double arrow indicates the change occurring with different $(d_{z^3-r^2})$ symmetry at E_F as discussed in the text.

not exhibit this behavior generally, because of final-state coupling of the 5p photohole with the 5d state, the outgoing electron can be of d character and can exhibit some of the symmetry characteristics of the valence 5d levels.³ This coupling can occur more strongly with the $5p_{3/2}$ level than the $5p_{1/2}$ because of the well-defined spin orientation of the initial-state eigenspinors that contribute to the $5p_{3/2}$ level (states of $m_j = \pm \frac{3}{2}$). This coupling becomes anisotropic when there is some local spin ordering of the unoccupied 5d states near the Fermi energy, 1,3,4 if we neglect crystal-field effects. If the terbium 5d level does exhibit some magnetic ordering, enhancement of the $5p_{3/2}$ feature over the $5p_{1/2}$ level in some photoemission geometries should occur, consistent with our observations. Similar final-state photoemission effects have been observed by Fadley and co-workers⁵⁴⁻⁵⁷ for 3d transition metals and have provided some measure of magnetic ordering. Related phenomena are also expected in x-ray absorption spectroscopy.58

Reversible changes in the *p*-level anisotropy, across the terbium Curie temperature (T_c) cannot be a result of band structure or crystal field effects. Crystal-field effects should exhibit no temperature dependence. The results presented here indicate that the *p*-level anisotropy is a result, at least in part, of magnetic ordering as noted in a preliminary communication.⁴

Theoretical studies of rare-earth^{22,23} surfaces have suggested that the crystal-field potential at the surface may dominate and, as outlined by Goedkoop,¹² could alter the

x-ray dichroism of terbium thin films. Arguments applied to gadolinium overlayers on Cu(100) (Ref. 1) and terbium overlayers on Ni(110) (Ref. 12) suggest that the crystal-field effects would have to be unrealistically large to account for unusual deviations in the p-level anisotropy from unity. While the *p*-level anisotropy may still, in part, be a result of crystal-field effects, the results presented here indicate that the p-level anisotropy is largely a result of magnetic ordering. The p-level anisotropies for terbium overlayers on Cu(100) deviate little from unity as seen in Fig. 5. Since the results in Fig. 5 are for terbium films at temperatures well above T_c (300 K) the results are representative of paramagnetic terbium. The average p-level anisotropy of 0.82 ± 0.05 differs by only 18% from unity. This deviation we attribute to crystal-field effects, or local magnetic ordering. Crystal-field effects are anticipated to be greater for the more open surfaces.¹² Our crystal-field effect for Cu(100) is therefore likely to be larger than that observed for Ni(111).

While there are substantial *p*-level anisotropies observed above the terbium Curie temperature for thin terbium overlayers on Ni(111), this can be reconciled with magnetic ordering. At temperatures of 300 K, while above the Curie temperature of terbium, this is well below the Curie temperature of nickel [627 K (Ref. 59)]. Thus, for very thin overlayers of terbium on Ni(111), the terbium overlayer is in the applied magnetic field of the substrate. This induces some magnetic ordering as in a paramagnet:⁵⁹

$$M = \mu_B^2 B N(E_F) . \tag{1}$$

This induced ordering will damp away from the interface. The damping will depend on a variety of factors such as the domain size, orientation of magnetization, and the coupling between terbium and nickel for ferromagnetic terbium, but for paramagnetic terbium, our results are consistent with the Ginzburg-Landau model of Mathon²⁶⁻²⁸ as we shall demonstrate below.

For thick films of terbium on Ni(111), the p-level anisotropy decreases dramatically away from unity as the temperature of the film is reduced to below T_c . Since the terbium 5d band is of $d_{3z^2-r^2}$ character for the thick films, we can compare our results with those obtained for gadolinium thin films on Cu(100) with identical 5d character. For gadolinium on Cu(100), the *p*-level anisotropy was observed to decrease with decreasing temperature rather than increase,³ with some evidence suggesting that this occurred as a result of a component of magnetization along the surface normal.¹ The results presented for ferromagnetic Tb on Cu(100) in Fig. 4 resemble those results reported for ferromagnetic Gd on Cu(100).³ We conclude that the ferromagnetic ordering of thick terbium films is accompanied by a change in the *p*-level anisotropy. The p-level anisotropy serves as a means of probing and observing the onset and presence of ferromagnetic order in rare-earth containing films.

For the thinner films of terbium on Ni(111), the *p*-level anisotropy increases rather than decreases with increasing magnetic order (decreasing temperature) because the density of states near the Fermi energy has a $d_{xz,yz}$ like character, resulting in apparent changes in the *p* to *d* cou-

pling in the final state. In general, our temperaturedependent results are consistent with temperature- and thickness-dependent dichroic effects observed for terbium overlayers on Ni(110) (Ref. 12) and polarization effects observed for terbium overlayers on Fe(100).¹⁵

There is experimental evidence that the magnetization of the Ni(111) surface is in the plane of the surface.⁶⁰ The results from the p-level anisotropy are consistent with this orientation of the magnetic moment because of the behavior of the *p*-level anisotropy which goes to unity as $z \rightarrow \infty$. The *p*-level anisotropies for Tb on Ni(111), for the thinner films, differ substantially from the p-level anisotropies observed for ferromagnetic Tb and Gd on Cu(100) consistent with the different magnetization axis for these two systems obtained by combining p-level anisotropy and constant initial-state photoemission results.³ Large in-plane magnetizations have also been observed for Gd on Fe(100) (Refs. 14 and 15) and Tb on Fe(100),¹⁵ for both $T > T_c$ and $T < T_c$. The substrate magnetization can overcome the tendency toward the anisotropic magnetization along the surface normal. The energy of the magnetic anisotropy is relatively small, even for the ferromagnet, with a value about 0.5 meV/atom or less.⁶¹ Since the paramagnet will have a smaller anisotropy energy than the ferromagnet, it is unsurprising from Eq. (1) that the substrate magnetization can dominate the overlayers.

GINZBURG-LANDAU THEORY APPLIED TO RARE-EARTH OVERLAYERS

There have been a number of theoretical studies in which the spatially dependent magnetization $M(\mathbf{r})$ has been described for films, alloys, and ferromagnetic multilayers by applying the Ginzburg-Landau formulation.²⁶⁻³⁶ Here, we apply the method to a paramagnetic film on a ferromagnetic substrate and also make some comments on its extension to a ferromagnetic film. The free energy per unit volume in the Ginzburg-Landau formulation^{35,62} is

$$f(\mathbf{r}) = f_0(\mathbf{r}) + \frac{1}{2} \mathbf{A} [\mathbf{M}(\mathbf{r})]^2 + \frac{\mathbf{B}}{4} [\mathbf{M}(\mathbf{r})]^4 - \frac{1}{2} \mathbf{M}(\mathbf{r}) \cdot \mathbf{H}^m - \mathbf{M}(\mathbf{r}) \cdot \mathbf{H} + \frac{1}{2} C [\nabla \mathbf{M}(\mathbf{r})]^2 .$$
(2)

The first term $f_0(\mathbf{r})$ is the free energy per volume in the absence of magnetization. Also, the order parameter $M(\mathbf{r})$ is the magnetization in the film. If, for example, the substrate is a single domain ferromagnetic crystal, then the magnetization vector is $\mathbf{M}(\mathbf{r}) = \hat{\mathbf{e}}_{\mathbf{x}} M(\mathbf{r})$, with the x axis as the easy axis of magnetization. This assumes that the film is a linear magnetic material with magnetization parallel to the inducing field. The fields \mathbf{H}^m and \mathbf{H} are the demagnetization and applied field, respectively, while the Ginzburg-Landau coefficients A, B, and C are temperature-dependent parameters. In particular, $A = A(T) \cong (T - T_c)\overline{\alpha}$ is generally assumed, with $\overline{\alpha} > 0$ and independent of T. The constant B is positive (or the transition would be first order) and can be related to spin and temperature.^{37,63} The temperature dependence of Aand B near T_c is rather suspect and does not agree with the available data.^{15,37} The constant C is discussed by Suhl⁶⁴ and Murata and Doniach⁶⁵ and is positive. We will apply the formulation at a fixed temperature and thereby not require temperature dependence.

In the Gaussian approximation, the static magnetization $M_0(r)$ is found by solving $\delta F / \delta M = 0$. This approximation will be valid except in the immediate vicinity of the critical point. Applying this, and setting H=0yields^{35,37,66}

$$AM_0(y) + BM_0(y)^3 - C \frac{d^2 M_0(y)}{dy^2} = H_0^m(y) .$$
 (3)

The coordinate y is the distance of the considered plane in the overlayer film to the interface. Hence $0 \le y \le z$ where z is the film thickness. From symmetry considerations, we expect $M_0(\mathbf{r})$ will not depend upon the in-plane coordinates. Thus $H_0^m(y)$ is the component of \mathbf{H}^m along the magnetization direction.

Schwenk, Fishman, and Schwabl³⁵ have considered the case of periodic multilayers of two alternating materials. When the in-plane dimensions are much greater than the layer thickness, they show that H_0^m is zero. These conditions hold in our experiments, and we will neglect H_0^m . Both in our rare-earth experiments, and those of Landolt and co-workers,^{14,15} the magnetization appears to be largely "in plane." Thus in our experiment for paramagnetic Tb on Ni(111), those of Landolt and co-workers for Tb or Gd on Fe(100) (Refs. 14 and 15) and geometries of Schwenk and co-workers³⁵ $\mathbf{H}^m = \mathbf{B} - 4\pi \mathbf{M}$ and very restrictive boundary conditions apply, setting $\mathbf{H}^m = -4\pi M_{\perp} = 0$. Limiting ourselves to the *static* magnetization, and deleting the subscripts of Eq. (3), we can write

$$-C\frac{d^2M(y)}{dy^2} + AM(y) + B[M(y)]^3 = 0.$$
 (4)

Analysis of $M(\mathbf{r})$ as a scalar is valid (as indicated above) for the present results where $T > T_c$.

If $T < T_c$, a vector model is more appropriate as discussed elsewhere.⁶⁵ Due to the antiferromagnetic coupling of the rare-earth overlayers with transition-metal substrates,^{11,15,17} both parallel and perpendicular components of $\mathbf{M}(\mathbf{r})$ (Ref. 12) exist and must be considered. A parallel component arises from the necessity of satisfying $\nabla \cdot \mathbf{B} = 0$ and the shape anisotropy.

For $T < T_c$ we can write $\mathbf{M}(\mathbf{r}) = M_{\parallel}(\mathbf{r})\hat{e}_{\parallel} + M_{\perp}(\mathbf{r})\hat{e}_{\perp}$, with M_{\parallel} and M_{\perp} as the components of \mathbf{M} that are parallel and perpendicular to the interface, respectively. Noting that the third term of Eq. (2) is $(B/4)[\mathbf{M}(\mathbf{r})\cdot\mathbf{M}(\mathbf{r})]^2$, Eq. (2) becomes

$$f(\mathbf{r}) = f_0(\mathbf{r}) + \frac{A}{2} M_{\parallel}(\mathbf{r})^2 + \frac{A}{2} M_{\perp}(\mathbf{r})^2 + \frac{B}{4} M_{\parallel}(\mathbf{r})^4 + \frac{B}{2} M_{\parallel}(\mathbf{r})^2 M_{\perp}(\mathbf{r})^2 + \frac{B}{4} M_{\perp}(\mathbf{r})^4 - \frac{1}{2} \mathbf{M} \cdot \mathbf{H}^m - \overline{M} \cdot \mathbf{H} + \frac{C}{2} [\nabla M_{\parallel}(\mathbf{r})]^2 + \frac{C}{2} [\nabla M_{\perp}(\mathbf{r})]^2 .$$
(2')

The condition $\delta F/\delta M = 0$ is replaced by $\delta F/\delta M_{\parallel} = 0 = \delta F/\delta M_{\perp}$ to yield a pair of differential equations for M_{\parallel} and M_{\perp} that replaces Eq. (3). Due to

the term $(B/2)M_{\perp}(\mathbf{r})^2M_{\parallel}(\mathbf{r})^2$, these two equations will be coupled. These two coupled equations are then

$$-C\frac{d^2M_{\parallel}(y)}{dy^2} + AM_{\parallel}(y) + BM_{\parallel}(y)M(y)^2 = H_{\parallel}^m , \qquad (3')$$

$$-C\frac{d^2M_{\perp}(y)}{dy^2} + AM_{\perp}(y) + BM_{\perp}(y)M(y)^2 = H_{\perp}^m , \qquad (3'')$$

where, under some circumstances (i.e., very thin films), $H_{\parallel}^{m} = 0.^{35}$

Mathon has argued²⁶ that the Ginzburg-Landau theory can be applied to palladium overlayers on nickel for thickness values less than 10 to 15 monolayers. Here we apply the theory to results obtained for terbium films of thicknesses five monolayers or less.

The demagnetization field H^m is negligible in our paramagnetic overlayer. Returning to $T > T_c$, setting H^m to zero as in Eq. (4), and integrating Eq. (4), yields

$$\frac{1}{\kappa^2} \left[\frac{dM(y)}{dy} \right]^2 = [M(y)]^2 + b[M(y)]^4 + a , \qquad (5)$$

where b = B/2A and *a* is a constant of integration. The correlation length, dependent upon bulk properties of the overlayer, is κ^{-1} and is related to short-range magnetic order.³⁷ The value κ is defined by $\kappa = (A/C)^{1/2}$.

The second integral yields the solution for M(y):

$$\kappa y = \int_{M(y)}^{M(0)} \frac{dM(y)}{\{b[M(y)]^4 + [M(y)]^2 + a\}^{1/2}}$$
(6)

assuming that M(0) > M(y) within the layer, as is certainly the case for a paramagnetic layer on a ferromagnetic substrate. We may also expect the sign choice for the square root to be positive for the case of a ferromagnetic layer on a ferromagnetic substrate if the substrate is the stronger ferromagnet.

The two constants of integration of Eq. (6), M(0) and a, can be conveniently expressed using length parameters λ and γ by

$$\frac{1}{\gamma} = \frac{-1}{M(0)} \left. \frac{dM(y)}{dy} \right|_{y=0}, \tag{7a}$$

$$\frac{1}{\lambda} = \frac{-1}{M(z)} \frac{dM(y)}{dy} \bigg|_{y=z} .$$
(7b)

The length λ describes the free surface and is analogous to the free surface extrapolation length introduced by Binder and Hohenberg²⁹ in their discussion of the Lenz-Ising model. Similarly, γ characterizes the interface. Mathon^{26,27} has given values for λ and γ by studying magnetization data for palladium films on a nickel substrate.

Combining Eqs. (5) and (7) yields a pair of equations relating the five constants $a, M(0), M(z), \lambda$, and γ :

$$[(\kappa\gamma)^{-2} - 1][M(0)]^2 - b[M(0)]^4 = a , \qquad (8a)$$

$$[(\kappa\gamma)^{-2} - 1][M(z)]^2 - b[M(z)]^4 = a .$$
(8b)

By substituting z = y into Eq. (6) we can obtain

$$\kappa z = \int_{M(z)}^{M(0)} \frac{dM(y)}{\{b[M(y)]^4 + [M(y)]^2 + a\}^{1/2}} .$$
(9)

Hence if any two of the five constants are known, the remaining constants can be ascertained by applying Eqs. (8) and (9).

Interpretation of λ follows from Eq. (7b). If $M(y) \sim e^{-\kappa y}$ describes the magnetization near the free surface, then $\kappa \lambda = 1$. If the free surface magnetization is larger than predicted by an exponential decay (a large penetration depth κ^{-1}) then $\kappa\lambda > 1$, corresponding to a small value for $|M'(y)|_{y=z}$. However, M(z) < M(y) will still hold for y < z, thus the free surface is weakly enhanced. When $0 < \kappa \lambda < 1$, then $|M'(y)|_{y=z}$ is of a larger size than would be the case for a simple exponential decay. Then the surface magnetization is suppressed. If $-1 < \kappa \lambda < 0$, then there is an increase in M(z), relative to the layers beneath the surface. In this case $M'(y)|_{y=z}$ is positive and large (thus representing a live surface layer). Finally, for $\kappa\lambda < -1$, M(y) increases more strongly than $exp(\kappa y)$ near the free surface and the surface layer is strongly enhanced. It should be noted that if M(y) obeys $M(y) = M(0)e^{-\kappa y}$ throughout the entire film, then $\lambda = \gamma = \kappa^{-1}$.

The integral in Eq. (6) can be cast in the form of incomplete elliptic integrals of the first kind defined by

$$F(\phi,k) = \int_0^{\phi} \frac{d\alpha}{(1-k^2\alpha^2)^{1/2}} .$$
 (10)

As noted already, B > 0 and hence b > 0 for paramagnetic terbium. Standard identities⁶⁷ allow the solutions for M(y) to be rewritten. For the case 0 < 4ab < 1,

$$M_{+}\sqrt{b} \kappa y = F(\alpha_{0},q) - F(\alpha_{v},q) , \qquad (11)$$

with

$$M_{\pm} = (2b)^{-1/2} (1 \pm \sqrt{1 - 4ab})$$
, (12a)

$$q = (M_{+}^{2} - M_{-}^{2})^{1/2} / M_{+} , \qquad (12b)$$

$$\alpha_{y} = \arctan[M(y)/M_{-}] . \qquad (12c)$$

If 4ab > 1, then

$$(ab)^{1/4} \kappa y = F(\beta_y, \xi) - F(\beta_0, \xi) , \qquad (13)$$

with

$$\cos\beta_{y} = \frac{M(y)^{2} - \sqrt{a/b}}{M(y)^{2} + \sqrt{a/b}}$$
, (14a)

$$\xi = \frac{1}{2} (ab)^{-1/4} [(1+\eta^2)^{1/2} - 1] , \qquad (14b)$$

$$\eta = 4ab - 1 \ . \tag{14c}$$

For a < 0, the result is

$$\sqrt{\varphi}\kappa y = F(\epsilon_0, S) - F(\epsilon_y, S) , \qquad (15)$$

with

 $\varphi =$

$$\sqrt{1+4|a|b}$$
,

$$\cos\epsilon_{y} = \frac{1}{M(y)} \sqrt{(\varphi - 1)/2b} \quad , \tag{16b}$$

(16a)

$$S = \frac{1}{\sqrt{2}}\sqrt{(1/\varphi) + 1}$$
 (16c)

In principle, if sufficiently extensive data for M(y) are available, comparison with Eqs. (11), (13), and (15) will allow determination of κ , b, a, and M(0). This would permit us to derive λ and γ . Here, however, we will only attempt to fit our data to the case of b = 0, in harmony with the fact that b is generally very small for a paramagnetic material. The result for M(y) can be found from Eq. (4) or from Eq. (6) by setting b = 0. The result is

$$M(y) = Re^{-\kappa y} + Te^{\kappa y} , \qquad (17a)$$

where the two constants of integration, R and T, replace the original pair of constants M(0) and a, and obey R > T > 0.

The function M(y) is really a function of y and z, i.e., M(y,z). Since photoemission is a surface sensitive probe under our experimental conditions we have, in fact, measured M(z,z). Assuming M(y,z) is independent of z, we then write

$$M(z) = Re^{-\kappa z} + Te^{\kappa z} , \qquad (17b)$$

which corresponds to our measurement.

Since for very thick films, the free surface magnetization approaches zero, the constant $T \rightarrow 0$. This implies T is small. In fitting Eq. (17) to the data for paramagnetic terbium, we restrict the fit to the case for which $T \ll R$, allowing for the second term in Eq. (17) to be omitted. Thus

$$M(z) \cong Re^{-\kappa z} . \tag{18}$$

The *p*-level anisotropy is unity with no magnetic ordering and (neglecting crystal-field effects) thus

$$\frac{\beta_p(z)}{\beta_s(z)} - q = pM(z) , \qquad (19)$$

where p is an appropriate scaling constant, and q is unity with no crystal-field effects (and 0.82 to 1.2 using our experimentally measured crystal-field effect and assuming this deviation from unity is not altered by short-range magnetic order). We have fit this equation to our data for terbium on Ni(111) as shown in Fig. 7 (assuming $q \simeq 1.0$), and the agreement with this exponential profile is good. In fitting this data, we use the fact that photoemission is surface sensitive. The small deviations of the experimental data from the exponential profile are a result of errors in our estimation of the terbium coverage.

This Ginzburg-Landau theory can also be applied to the results obtained for terbium on Fe(100) from Auger electron polarization studies by Paul, Landolt, and coworkers.¹⁵ These results plotted in Fig. 8 have been fitted to Eq. (18) as well. For terbium on Ni(111) we ascertain that the correlation length $\kappa^{-1}=0.71\pm0.19$ monolayers (2.5 ± 0.7 Å) which is in reasonable agreement with the value of $\kappa^{-1}=1.0$ monolayers (~ 3.5 Å) obtained for terbium on Fe(100) considering the difficulties in estimating the terbium overlayer thickness and the differences in the electron mean free path (the surface sensitivity) between the two spectroscopies employed. (Corrections for the



FIG. 7. The Ginzburg-Landau model fitted to the *p*-level anisotropy data for paramagnetic terbium. The values of $\kappa^{-1}=0.71$ (~2.5 Å) and q=1 have been used.

experimentally derived crystal-field effects have little effect on κ^{-1} .)

As pointed out earlier, the correlation length is related to the short-range magnetic order for $T > T_c$ and is, in principle, a bulk property.^{37,66} For bulk terbium the inverse correlation length has been obtained from the short-range magnetic order measured by neutron diffraction.⁶⁸ Extrapolating these results to our temperature of 300 K gives us values of $\kappa^{-1}=2.8$ Å along the c axis and $\kappa^{-1}=4.9$ Å along the basal plane of bulk terbi-



FIG. 8. The Ginzburg-Landu model fitted to the Auger electron polarization data for terbium on Fe(100) taken from Ref. 15. Data for room temperature (+) and 170 K (\odot) have been plotted. The Ginzburg-Landau model has been fitted to the room-temperature data using a value of $\kappa^{-1}=0.98$ (~ 3.5 Å). Notice the overall similarity of this data and those shown in Fig. 6.

um. The correlation length for bulk terbium along the c axis is in surprisingly good agreement with our value of κ^{-1} . This result suggests that the terbium overlayer, while showing no crystal order in LEED or reflection high-energy electron diffraction (RHEED), grows with an hcp structure with the basal plane parallel with the surface, or least has a Tb-Tb lattice constant close to that of the in-plane basal face lattice constant.

The effective values obtained for the correlation length κ^{-1} for paramagnetic terbium overlayers (2.5–3.5 Å or less than an atomic diameter) are much less than the correlation length of $\kappa^{-1}=5$ Å (much more than an atomic diameter of Pd of 2.75 Å) obtained for palladium (a nearly ferromagnetic metal) on nickel.^{27,31} This difference is particularly apparent if one considers that the experimental spectroscopies employed are *not* perfectly surface sensitive. This is unsurprising in view of the far more localized interactions expected for the rare-earth metals as opposed to the transition metals. The terbium results are in good agreement with the correlation length of 2.5±0.5 Å estimated for Gd on Fe(100) at $T/T_c = 1.22$ (Ref. 14) (as compared with a $T/T_c = 1.4$ for the terbium results reported herein).

Recall, if the decay rate is a simple exponential $M(y) \sim e^{-\kappa y}$ over $0 \leq y \leq z$, then $\lambda^{-1} = \kappa$ follows from Eq. (7). Returning to the data for Tb, the fact that its paramagnetic phase follows an exponential decay so well indicates that $\kappa\lambda \sim 1$. Hence there exists at most very weak suppression or very weak enhancement at the Tb free surface. The Tb free surface acts like a paramagnet and does not show either strong enhancement or "live" behavior. A similar result (i.e., $\kappa\lambda \sim 1$) was found by Gradmann and Bergholz⁶² for Pd overlayers on Ni, at room temperature.

Boundary conditions [Eqs. (7) and (8)] at the interface result in a diminution of the magnetization at the ferromagnetic substrate surface as a result of the paramagnetic overlayer. Spin-dependent photoemission studies of terbium on Fe(100) (Ref. 17) have observed a reduction of the polarization of the Fe(100) substrate valence emission, consistent with these boundary conditions. CONCLUSION

By measuring the *p*-level anisotropy above and below the terbium Curie temperature, we have demonstrated conclusively that the *p*-level anisotropy can be used to probe magnetic order in rare-earth overlayers. Our results show that terbium overlayers magnetically interact with ferromagnetic substrates such as nickel or iron. The ferromagnetic substrates clearly induce some magnetic order in very thin (<4 monolayer equivalents) terbium films which damped with increasing distance away from the interface in a manner consistent with Ginzburg-Landau theory. We find the correlation length for terbium to be $0.71 \le \kappa^{-1} \le 1.0$ monolayer (2.5–3.5 Å) at 300 K. This result is consistent with the bulk correlation length, and results reported for gadolinium.¹⁴

The smaller correlation length found for paramagnetic terbium, in comparison with paramagnetic Pd may reflect that the magnetic interactions in the rare-earth metals are far more localized than in palladium. Our experimental and theoretical analysis indicates that paramagnetic terbium on Ni(111) exhibits a magnetization that follows an exponential decay from the ferromagnet-paramagnet interface.

We have also established that paramagnetic terbium on Fe(100) exhibits an induced magnetization that decays exponentially away from the interface using the results of Landolt and co-workers.¹⁵ It is unsurprising that both our *p*-level anisotropy data and Landolt and co-workers' effective electron spin-polarization data lead to the same conclusion, given the results of the Ginzburg-Landau theory.

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*To whom all correspondence may be addressed.

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